

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/022,124	VAN WERSHOVEN, LOESJE MA	
		Examiner	Art Unit	Page 1 of 1
		Hiep Nguyen	2816	

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	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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